Application/Control No. Applicant(s)/Patent Under Reexamination 10/600,065 SHIEH ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 Dang T. Nguyen 2824 **U.S. PATENT DOCUMENTS Document Number** Date Name Classification Country Code-Number-Kind Code MM-YYYY US-2003/0208663 A1 11-2003 711/156 Van Buskirk et al. Α US-В US-С US-D US-Ε US-US-G US-Н US-Ι US-US-Κ US-L US-М FOREIGN PATENT DOCUMENTS **Document Number** Date Name Classification Country Country Code-Number-Kind Code MM-YYYY 0 Ρ Q R S Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U W

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